

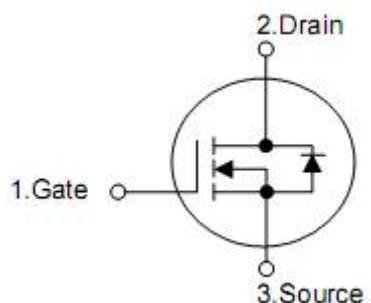
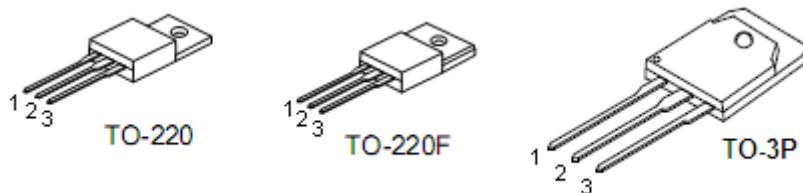
1. Description

This Power MOSFET is produced using KIA's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

2. Features

- $R_{DS(on)}=0.20\Omega$ @ $V_{GS}=10V$
- Low gate charge (typical 50nC)
- Fast switching capability
- Avalanche energy specified
- Improved dv/dt capability

3. Pin configuration



Pin	Function
1	Gate
2	Drain
3	Source

4. Absolute maximum ratings

Parameter		Symbol	Ratings			Units
			TO220	TO220F	TO3P	
Drain-source voltage		V_{DSS}	400			V
Gate-source voltage		V_{GSS}	± 30			V
Drain current continuous	$T_c=25^\circ\text{C}$	I_D	20	20*	20	A
	$T_c=100^\circ\text{C}$		10.8	10.8*	10.8	A
Drain current pulsed (note1)		I_{DP}	72	72	72	A
Avalanche energy	Repetitive (note1)	E_{AR}	20.25			mJ
	Single pulse (note2)	E_{AS}	711			mJ
Peak diode recovery dv/dt (note 3)		dv/dt	4.5			V/ns
Total power dissipation	$T_c=25^\circ\text{C}$	P_D	202.5	40	202.5	W
	derate above 25°C		1.62	0.32	1.62	W/ $^\circ\text{C}$
Junction temperature		T_J	$+150$			$^\circ\text{C}$
Storage temperature		T_{STG}	$-55\text{--}+150$			$^\circ\text{C}$

*Drain current limited by maximum junction temperature.

5. Thermal characteristics

Parameter	Symbol	Ratings			Units
		TO220	TO220F	TO3P	
Thermal resistance, junction-ambient	R_{thJA}	62.5	62.5	62.5	$^\circ\text{C/W}$
Thermal resistance, case-to-sink typ.	R_{thCS}	0.5	-	0.5	
Thermal resistance, Junction-case	R_{thJC}	0.61	3.11	0.61	

6. Electrical characteristics

($T_J=25^\circ\text{C}$,unless otherwise specified)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Off characteristics						
Drain-source breakdown voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	400	-	-	V
Zero gate voltage drain current	$I_{\text{DS}}^{\text{SS}}$	$V_{\text{DS}}=400\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
		$V_{\text{DS}}=320\text{V}, T_c=125^\circ\text{C}$	-	-	10	μA
Gate-body leakage current	I_{GSS}	$V_{\text{GS}}=30\text{V}, V_{\text{DS}}=0\text{V}$	-	-	100	nA
		$V_{\text{GS}}=-30\text{V}, V_{\text{DS}}=0\text{V}$	-	-	-100	nA
Breakdown voltage temperature coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	$I_{\text{D}}=250\mu\text{A}$	-	0.5	-	$\text{V}/^\circ\text{C}$
On characteristics						
Gate threshold voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	3.0	-	5.0	V
Static drain-source on-resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{DS}}=10\text{V}, I_{\text{D}}=9.0\text{A}$	-	0.20	0.25	Ω
Dynamic characteristics						
Input capacitance	C_{iss}	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	-	2135	-	pF
Output capacitance	C_{oss}		-	255	-	pF
Reverse transfer capacitance	C_{rss}		-	35	-	pF
Switching characteristics						
Turn-on delay time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=200\text{V}, I_{\text{D}}=20.0\text{A}, R_{\text{G}}=25\Omega$ (note4,5)	-	50	-	ns
Rise time	t_r		-	170	-	ns
Turn-off delay time	$t_{\text{d}(\text{off})}$		-	90	-	ns
Fall time	t_f		-	80	-	ns
Total gate charge	Q_g	$V_{\text{DS}}=320\text{V}, I_{\text{D}}=20.0\text{A}, V_{\text{GS}}=10\text{V}$ (note4,5)	-	50	-	nC
Gate-source charge	Q_{gs}		-	10.5	-	nC
Gate-drain charge	Q_{gd}		-	24	-	nC
Drain-source diode characteristics						
Drain-source diode forward voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=20.0\text{A}$	-	-	1.4	V
Continuous drain-source current	I_{SD}		-	-	20.0	A
Pulsed drain-source current	I_{SM}		-	-	72	A
Reverse recovery time	t_{rr}	$I_{\text{SD}}=20.0\text{A}$ $dI_{\text{SD}}/dt=100\text{A}/\mu\text{s}$ (note4)	-	450	-	ns
Reverse recovery charge	Q_{rr}		-	5.5	-	μC

Note:1. Repetitive rating: pulse width limited by maximum junction temperature

2. $L=4.0\text{mH}, I_{\text{AS}}=20.0\text{A}, V_{\text{DD}}=50\text{V}, R_{\text{G}}=25\Omega$,staring $T_J=25^\circ\text{C}$

3. $I_{\text{SD}}\leq 20.0\text{A}, dI/dt\leq 200\text{A}/\mu\text{s}, V_{\text{DD}}\leq \text{BV}_{\text{DSS}}$, staring $T_J=25^\circ\text{C}$

4. Pulse test: pulse width $\leq 300\mu\text{s}$,duty cycle $\leq 2\%$

5. Essentially independent of operating temperature

7. Test circuits and waveforms

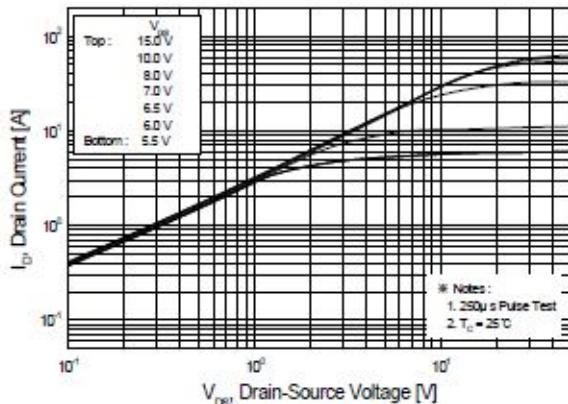


Figure 1. On-Region Characteristics

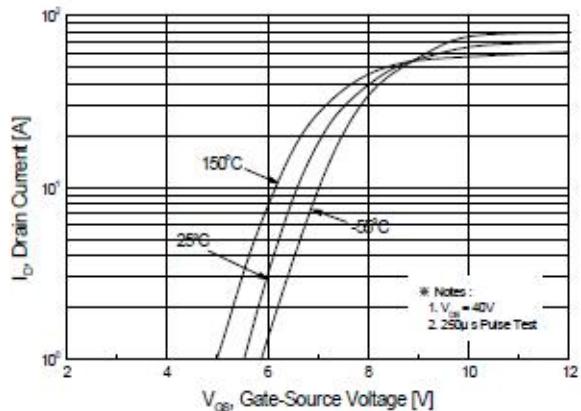


Figure 2. Transfer Characteristics

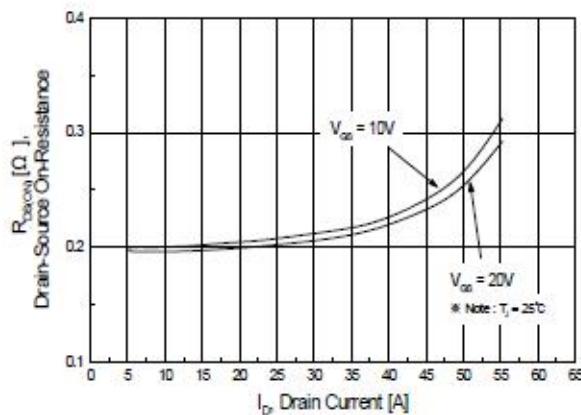


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

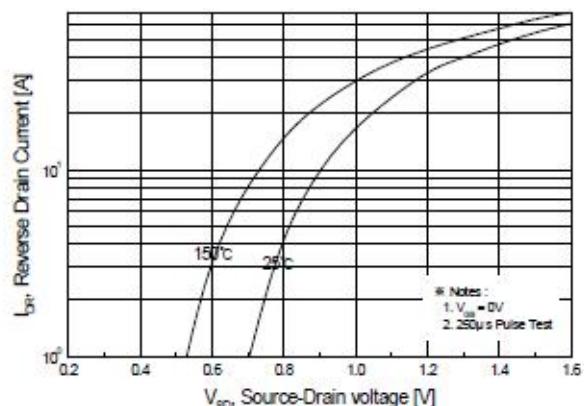


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

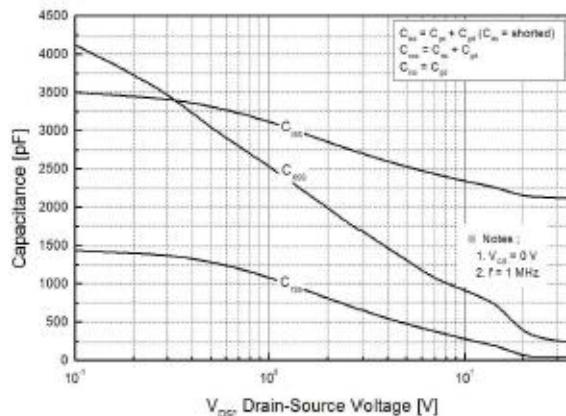


Figure 5. Capacitance Characteristics

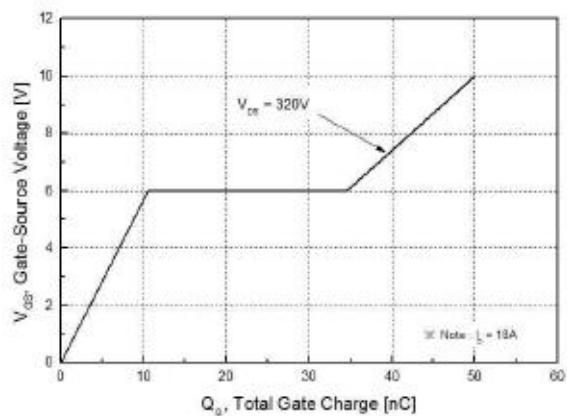


Figure 6. Gate Charge Characteristics

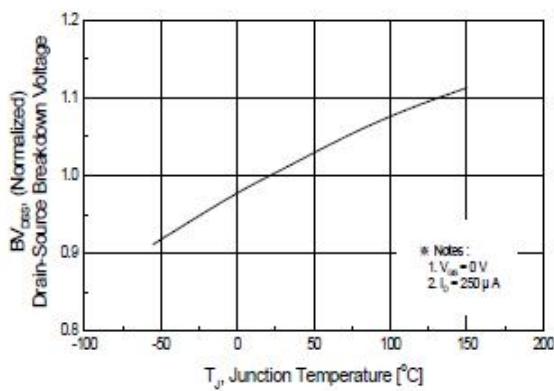


Figure 7. Breakdown Voltage Variation vs Temperature

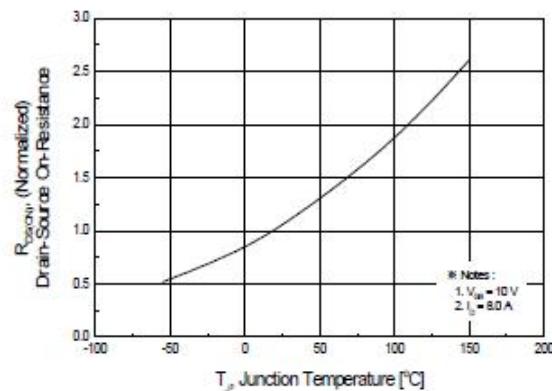


Figure 8. On-Resistance Variation vs Temperature

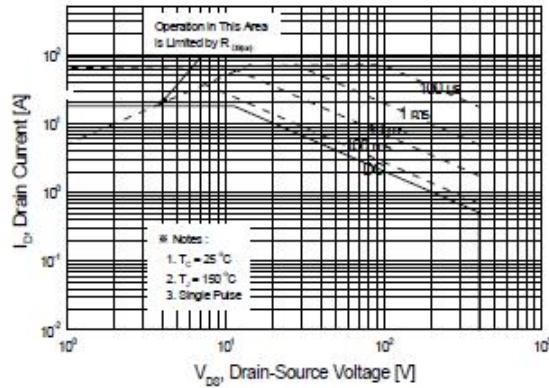


Figure 9-1. Maximum Safe Operating Area for TO-220

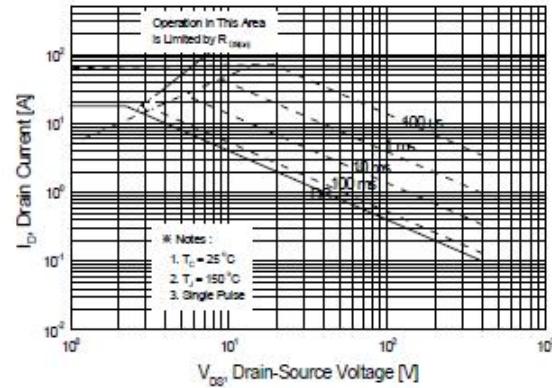


Figure 9-2. Maximum Safe Operating Area for TO-220F

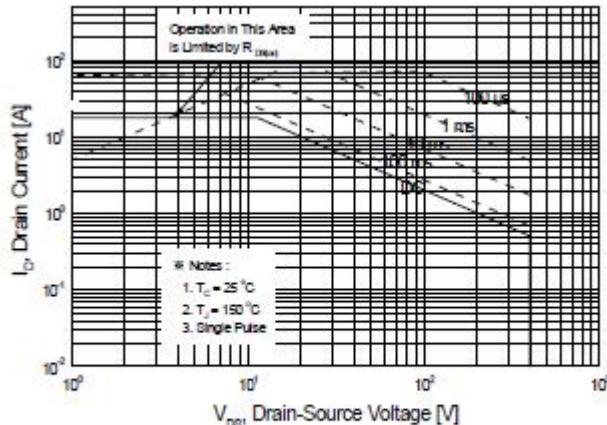


Figure 9-3 Maximum Safe Operating Area for TO-3P

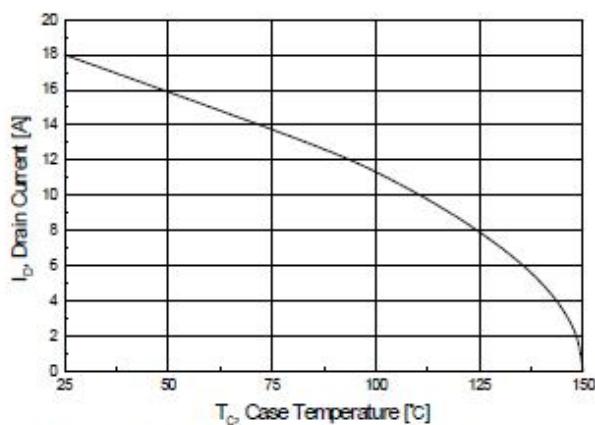


Figure 10. Maximum Drain Current vs Case Temperature

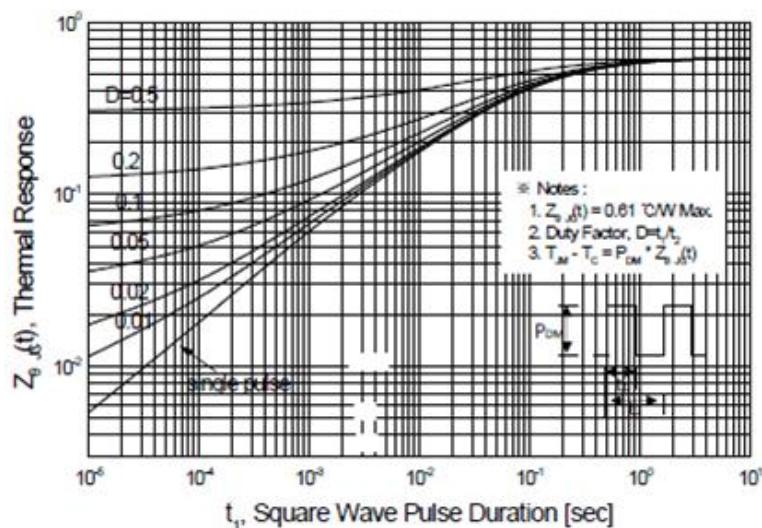


Figure 11-1. Transient Thermal Response Curve for TO-220

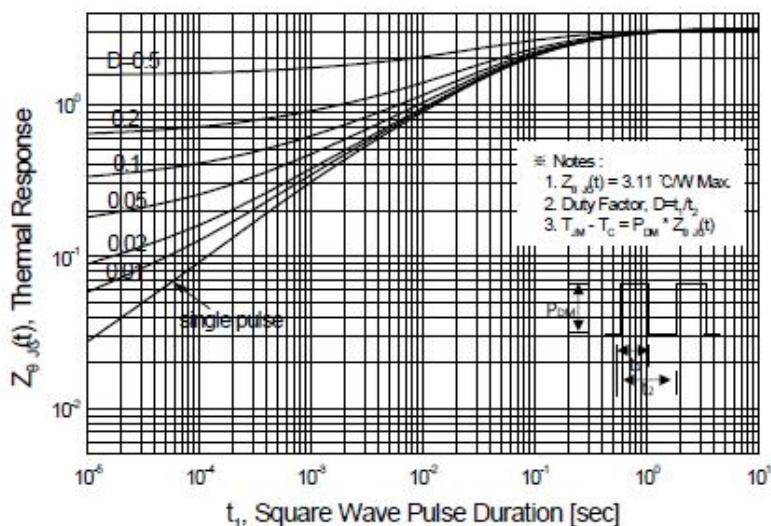


Figure 11-2. Transient Thermal Response Curve for TO-220F

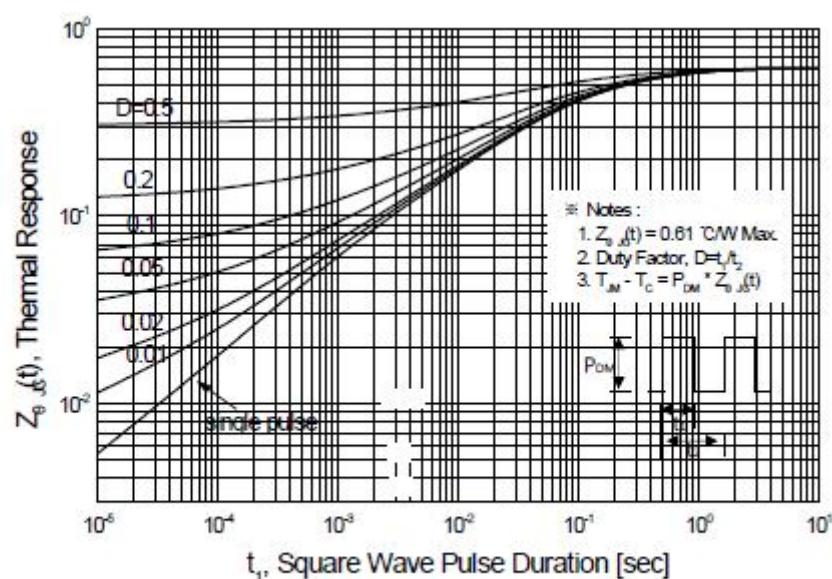


Figure 11-3 Transient Thermal Response Curve for TO-3P